

Search Notes

Application/Control No.

10/714,207

Examiner

Michael Trinh

Applicant(s)/Patent under
Reexamination

CHIU ET AL.

Art Unit

2822

SEARCHED

Class	Subclass	Date	Examiner
438	Updated previous subclasses	9/27/2006	MT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR